

**Search Notes**

Application/Control No.

10/617,784

Examiner

Edgardo San Martin

Applicant(s)/Patent under  
Reexamination

TAKAHASHI ET AL.

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
181	166-173	6/23/2005	ESM
381	423,202	7	7
	386,392		
	426-429		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
181	166-173	6/26/2005	ESM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST	6/23/2005	ESM